

Shot Noise in the Presence of Spin-Flip Scattering

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Shot noise is a time-dependent current fluctuation due to the discrete character of the electron charge. Here we address shot noise in a spin-resolved tunneling system under the influence of spin-flip scattering within a master equation approach. We find that the average current $\langle I \rangle$ and Fano factor γ (“normalized noise”) present contrasting behavior for differing spin-flip time ratios: $\langle I \rangle$ decreases while γ increases for $\tau_{\uparrow\downarrow} > \tau_{\downarrow\uparrow}$ as compared to the $\tau_{\uparrow\downarrow} = \tau_{\downarrow\uparrow}$ case and vice versa for $\tau_{\uparrow\downarrow} < \tau_{\downarrow\uparrow}$.

Spin-dependent transport in tunneling structures is a fascinating subject. So far the bulk of experimental and theoretical investigations has been on metallic layered systems. This focus is now turning to more versatile semiconductor heterostructures. More specifically, spin-polarized transport – an obvious possibility in spin-dependent geometries [1] – has just recently been achieved in Mn-based II-VI and III-V doped semiconductor diodes [2, 3, 4]. These seminal experiments open up new venues for further advances in the emerging field of spintronics in semiconductors – where the spin of the carrier, rather than its charge, runs the show [5, 6].

So far spin injection [2, 3, 4] has been demonstrated only at low temperatures and in the *diffusive* limit [7]. Spin injection at room temperatures, relevant for real device applications, remains a challenge. However, investigations at low temperatures are fundamentally important for understanding general features/properties of spin-polarized transport which may turn out relevant at high temperatures. Conceivably, some detrimental spin-flip effects contaminating low temperature transport may very well survive at higher temperatures.

Here we investigate spin-flip effects on transport through a spin-resolved tunneling system [8], Fig. 1. More specifically, we are interested in spin-flip effects on shot noise. Shot noise is a dynamic current fluctuation arising from the *particular* (or granular) nature of the electron charge. Shot noise investigations have become a major subject of research in the last decade or so [9, 10]. Common wisdom has it that shot noise measurements supplement information contained in the average current. Here in particular we find that spin-flip processes affect the average current and shot noise

in a *contrasting* fashion; in a limited parameter range, while shot noise is suppressed the average current is enhanced and vice versa, Fig. 2.

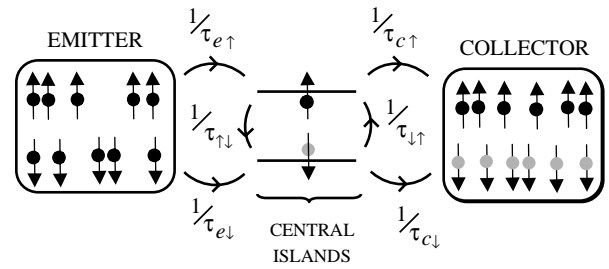


Figure 1. Schematic representation of a resonant-tunneling system with a semimagnetic quantum well/dot. Spin up electrons from the emitter can hop into the upper spin-up levels (“island up”) and subsequently either spin flip into the lower spin-down levels (“island down”) or hop out to the collector. Spin down electrons perform similar transitions. All these hops are described by “transition times” τ ’s; the corresponding transition rates are proportional to $1/\tau$ ’s as indicated. Note that hopping between the central islands involves spin flip processes characterized by $\tau_{\uparrow\downarrow}$ and $\tau_{\downarrow\uparrow}$.

Physical system. We consider a II-VI double-barrier tunneling structure with a Manganese-based quantum well/dot. In the presence of an external magnetic field, the *s-d* exchange interaction between a traversing electron and the *d* electrons of the Mn gives rise to a spin-dependent quantum well/dot potential. This in turn lifts the spin-up/spin-down degeneracy of the resonant level. Each exchange-split resonant level accepts electrons with only a well-defined spin component. Fig. 1 schematically shows the system geometry. In Fig. 1, the many possible electron transitions connecting the

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emitter, spin-split levels (“islands” up and down) and collector are described by transition rates proportional to $1/\tau$, where τ is, roughly speaking, the respective transition time. Observe that the hops between spin-resolved levels in Fig. 1 involve spin flip. Here we use distinct spin-flip times for the up-to-down and down-to-up transitions between the islands, i.e., $\tau_{\uparrow\downarrow} \neq \tau_{\downarrow\uparrow}$; this is certainly the case when the relevant spin-flip mechanism connecting the islands is the s - d exchange interaction [11]. Our description, however, does not rely on any specific form of the spin-flip mechanism.

Semiclassical description. We model spin-resolved tunneling through a quantum well/dot in terms of classical hops among emitter, spin-split levels and collector as shown in Fig. 1 (see also inset in Fig. 2). Our approach is based on rate equations for the ensemble averaged number of electrons $n_{\uparrow}(t)$ and $n_{\downarrow}(t)$ in the islands up and down, respectively. These equations are directly derived from the system population master equation describing the probability $p(n_{\uparrow}, n_{\downarrow}, t)$ of finding n_{\uparrow} and n_{\downarrow} electrons in the islands at time t . Island up (down) holds at most N_{\uparrow} (N_{\downarrow}). Our transition rates take into account that no electrons can hop into a full island (“Pauli principle”) or out of an empty one. This type of correlation does affect current fluctuations arising from the discreteness of the electron charge.

Average current and its fluctuations. From the rate equations mentioned above we can easily determine the average current through the system. In the steady state $\langle I \rangle = e\langle n_{\uparrow} \rangle / \tau_{c\uparrow} + e\langle n_{\downarrow} \rangle / \tau_{c\downarrow}$ (e : electron charge) and the average occupations $\langle n_{\uparrow,\downarrow} \rangle = n_{\uparrow,\downarrow}(t \rightarrow \infty)$ depend on the several hopping times τ ’s and $N_{\uparrow,\downarrow}$. The current fluctuation is defined in terms of the ensemble average current-current correlation function $\langle \delta i(t+t') \delta i(t') \rangle$. Experimentally, the relevant quantity is the spectral power of the shot noise measured (usually) at zero frequency, i.e., $S(0) = 2 \int \langle \delta i(t+t') \delta i(t') \rangle dt$. By introducing appropriate “hop-hop” correlation functions, which describe how likely a particular hop follows a previous one, we can relate $S(0)$ to the variance matrix of the system [12]. This 2×2 matrix is directly obtained from the master equation of the system. The resulting expressions for the zero-frequency shot noise $S(0)$ and the elements of the variance matrix ($\langle \delta n_{\uparrow} \delta n_{\downarrow} \rangle = \langle \delta n_{\downarrow} \delta n_{\uparrow} \rangle$, $\langle (\delta n_{\uparrow})^2 \rangle$, and $\langle (\delta n_{\downarrow})^2 \rangle$) are too lengthy to be shown here [13].

Results and discussions. Fig. 2 displays curves for both $\langle I \rangle / e$ (symbols) and the Fano factor $\gamma = S(0) / 2e\langle I \rangle$ (lines) for the resonant-tunneling system in Fig. 1, with differing spin-flip time ratios. The normalizing factor $2e\langle I \rangle$, usually called ‘classical or full’ shot noise (Schottky), denotes the shot noise power spectral density for a stream of *uncorrelated* electrons with average current $\langle I \rangle$. The Fano factor is a convenient means to assess how correlations affect shot noise. In Figure 2 both average current and Fano factor are strongly affected by spin-flip processes. This can be

more clearly observed for $\tau_{c\uparrow} / \tau_{e\uparrow}$ in the range 1 to 10 (or, equivalently, 0 to 1 in the horizontal log axis of Fig. 1) in which the flow of electrons from ‘island-up’ to the collector is suppressed. In this case, to arrive at the collector an electron has to necessarily go through ‘island-down’ thus undergoing spin flip. In this particular range, shot noise (Fano factor) and average current exhibit contrasting behavior for differing $\tau_{\uparrow\downarrow} / \tau_{\downarrow\uparrow}$ ratios; $\langle I \rangle$ decreases while γ increases for $\tau_{\uparrow\downarrow} > \tau_{\downarrow\uparrow}$ as compared to the $\tau_{\uparrow\downarrow} = \tau_{\downarrow\uparrow}$ case and vice versa for $\tau_{\uparrow\downarrow} < \tau_{\downarrow\uparrow}$. This trend is reversed in the $[-1, 0]$ range. Hence shot noise and the average current are distinctively sensitive to spin flip.

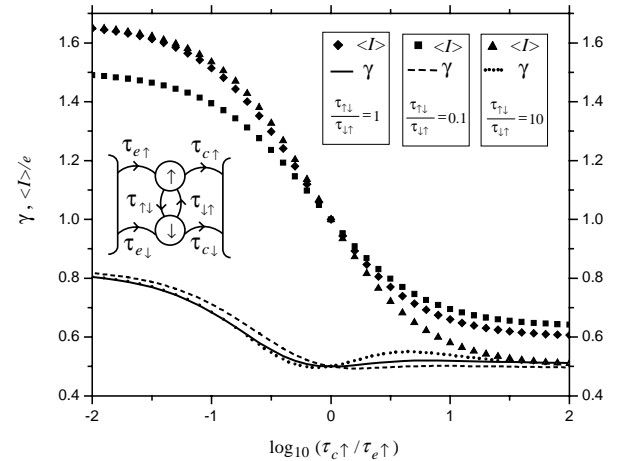


Figure 2. Average current and Fano factor for the resonant-tunneling system in Fig. 1 with differing spin-flip time ratios. We use $N_{\uparrow} = N_{\downarrow} = 1$, $\tau_{e\uparrow} = \tau_{e\downarrow} = \tau_{c\downarrow} = 1$, in all curves (symbols for average currents and lines for Fano factors). We see that $\langle I \rangle$ and γ depend on spin-flip scattering. All curves are particularly sensitive to the $\tau_{\uparrow\downarrow} / \tau_{\downarrow\uparrow}$ ratio. In the $[0, 1]$ range (horizontal axis), the average current and Fano factor exhibit contrasting behavior; $\langle I \rangle$ decreases while γ increases for $\tau_{\uparrow\downarrow} > \tau_{\downarrow\uparrow}$ as compared to the $\tau_{\uparrow\downarrow} = \tau_{\downarrow\uparrow}$ case and vice versa for $\tau_{\uparrow\downarrow} < \tau_{\downarrow\uparrow}$.

Sumarizing, we have discussed spin-flip effects on spin-dependent transport in semimagnetic junctions with spin-split resonant levels. Our semiclassical description in terms of rate and master equations allows us to calculate both the average current and shot noise; the latter in terms of the variance matrix of the system. Interestingly enough, we find that the average current and shot noise are sensitive to spin flip (between the spin-split levels) in a contrasting way. In a limited parameter range, while the average current decreases (increases) the shot noise increases (decreases) as function of the ratio $\tau_{\uparrow\downarrow} / \tau_{\downarrow\uparrow}$.

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